Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,874	SHAN ET AL.	
Examiner	Art Unit	
BRIAN P. YENKE	2622	

	0545	CUED			
SEARCHED					
Class	Subclass	Date	Examiner		
348	451,663, 665,667- 670,	8/29/2006	BPY		
	699-701				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		· · · · · · · · · · · · · · · · · · ·		
		<del>,</del>		

STRATEGY	
	EXMR
8/29/2006	BPY
	8/29/2006